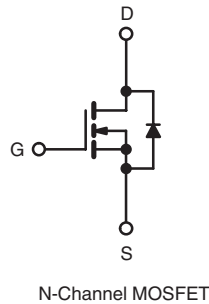
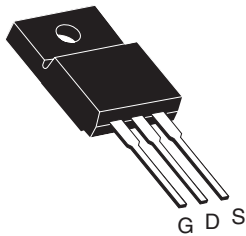


## Power MOSFET

| PRODUCT SUMMARY           |                 |     |
|---------------------------|-----------------|-----|
| $V_{DS}$ (V)              | 800             |     |
| $R_{DS(on)}$ ( $\Omega$ ) | $V_{GS} = 10$ V | 6.5 |
| $Q_g$ (Max.) (nC)         | 38              |     |
| $Q_{gs}$ (nC)             | 5.0             |     |
| $Q_{gd}$ (nC)             | 21              |     |
| Configuration             | Single          |     |

**TO-220 FULLPAK**

**FEATURES**

- Isolated Package
- High Voltage Isolation = 2.5 kV<sub>RMS</sub> (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available



Available

**RoHS\***  
COMPLIANT

**DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

**ORDERING INFORMATION**

|                |                |
|----------------|----------------|
| Package        | TO-220 FULLPAK |
| Lead (Pb)-free | IRFIBE20GPbF   |
|                | SiHFIBE20G-E3  |
| SnPb           | IRFIBE20G      |
|                | SiHFIBE20G     |

**ABSOLUTE MAXIMUM RATINGS**  $T_C = 25$  °C, unless otherwise noted

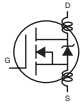
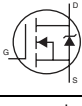
| PARAMETER  | SYMBOL           | LIMIT            | UNIT |          |
|--|------------------|------------------|------|----------|
| Drain-Source Voltage                             | $V_{DS}$         | 800              | V    |          |
| Gate-Source Voltage                              | $V_{GS}$         | $\pm 20$         |      |          |
| Continuous Drain Current                         | $V_{GS}$ at 10 V | $T_C = 25$ °C    | 1.4  | A        |
|  |                  | $T_C = 100$ °C   | 0.86 |          |
| Pulsed Drain Current <sup>a</sup>                | $I_{DM}$         | 5.6              |      |          |
| Linear Derating Factor                           |                  | 0.24             | W/°C |          |
| Single Pulse Avalanche Energy <sup>b</sup>       | $E_{AS}$         | 180              | mJ   |          |
| Repetitive Avalanche Current <sup>a</sup>        | $I_{AR}$         | 1.4              | A    |          |
| Repetitive Avalanche Energy <sup>a</sup>         | $E_{AR}$         | 3.0              | mJ   |          |
| Maximum Power Dissipation                        | $T_C = 25$ °C    | $P_D$            | 30   | W        |
| Peak Diode Recovery dV/dt <sup>c</sup>           |                  | dV/dt            | 2.0  | V/ns     |
| Operating Junction and Storage Temperature Range | $T_J, T_{stg}$   | - 55 to + 150    | °C   |          |
| Soldering Recommendations (Peak Temperature)     | for 10 s         | 300 <sup>d</sup> |      |          |
| Mounting Torque                                  | 6-32 or M3 screw |                  | 10   | lbf · in |
|  |                  |                  | 1.1  | N · m    |

**Notes**

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- $V_{DD} = 50$  V, starting  $T_J = 25$  °C, L = 172 mH,  $R_G = 25$   $\Omega$ ,  $I_{AS} = 1.4$  A (see fig. 12).
- $I_{SD} \leq 1.8$  A,  $dI/dt \leq 80$  A/ $\mu$ s,  $V_{DD} \leq 600$ ,  $T_J \leq 150$  °C.
- 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

| THERMAL RESISTANCE RATINGS       |            |      |      |      |
|----------------------------------|------------|------|------|------|
| PARAMETER                        | SYMBOL     | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient      | $R_{thJA}$ | -    | 65   | °C/W |
| Maximum Junction-to-Case (Drain) | $R_{thJC}$ | -    | 4.1  |      |

| SPECIFICATIONS $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted |                     |  |  |      |      |           |               |
|--|---------------------|--|--|------|------|-----------|---------------|
| PARAMETER  | SYMBOL              | TEST CONDITIONS  |  | MIN. | TYP. | MAX.      | UNIT          |
| <b>Static</b>  |                     |  |  |      |      |           |               |
| Drain-Source Breakdown Voltage   | $V_{DS}$            | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$  |  | 800  | -    | -         | V             |
| $V_{DS}$ Temperature Coefficient   | $\Delta V_{DS}/T_J$ | Reference to $25\text{ }^\circ\text{C}$ , $I_D = 1\text{ mA}$  |  | -    | 0.98 | -         | V/°C          |
| Gate-Source Threshold Voltage  | $V_{GS(th)}$        | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$  |  | 2.0  | -    | 4.0       | V             |
| Gate-Source Leakage  | $I_{GSS}$           | $V_{GS} = \pm 20\text{ V}$   |  | -    | -    | $\pm 100$ | nA            |
| Zero Gate Voltage Drain Current  | $I_{DSS}$           | $V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$   |  | -    | -    | 100       | $\mu\text{A}$ |
|  |                     | $V_{DS} = 640\text{ V}, V_{GS} = 0\text{ V}, T_J = 125\text{ }^\circ\text{C}$  |  | -    | -    | 500       |               |
| Drain-Source On-State Resistance   | $R_{DS(on)}$        | $V_{GS} = 10\text{ V}$   | $I_D = 0.84\text{ A}^b$  | -    | -    | 6.5       | $\Omega$      |
| Forward Transconductance   | $g_{fs}$            | $V_{DS} = 10\text{ V}, I_D = 0.84\text{ A}^b$  |  | 1.0  | -    | -         | S             |
| <b>Dynamic</b>   |                     |  |  |      |      |           |               |
| Input Capacitance  | $C_{iss}$           | $V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1.0\text{ MHz}$ , see fig. 5   |  | -    | 530  | -         | pF            |
| Output Capacitance   | $C_{oss}$           |  |  | -    | 150  | -         |               |
| Reverse Transfer Capacitance   | $C_{riss}$          |  |  | -    | 90   | -         |               |
| Drain to Sink Capacitance  | $C$                 | $f = 1.0\text{ MHz}$   |  | -    | 12   | -         |               |
| Total Gate Charge  | $Q_g$               | $V_{GS} = 10\text{ V}$   | $I_D = 1.8\text{ A}, V_{DS} = 400\text{ V}$ , see fig. 6 and 13 <sup>b</sup> | -    | -    | 38        | nC            |
| Gate-Source Charge   | $Q_{GS}$            |  |  | -    | -    | 5.0       |               |
| Gate-Drain Charge  | $Q_{GD}$            |  |  | -    | -    | 21        |               |
| Turn-On Delay Time   | $t_{d(on)}$         | $V_{DD} = 400\text{ V}, I_D = 1.8\text{ A}, R_G = 18\text{ }\Omega, R_D = 230\text{ }\Omega$ , see fig. 10 <sup>b</sup>                                |  | -    | 8.2  | -         | ns            |
| Rise Time  | $t_r$               |  |  | -    | 17   | -         |               |
| Turn-Off Delay Time  | $t_{d(off)}$        |  |  | -    | 58   | -         |               |
| Fall Time  | $t_f$               |  |  | -    | 27   | -         |               |
| Internal Drain Inductance  | $L_D$               | Between lead, 6 mm (0.25") from package and center of die contact  |  | -    | 4.5  | -         | nH            |
| Internal Source Inductance   | $L_S$               |  |  | -    | 7.5  | -         |               |
| <b>Drain-Source Body Diode Characteristics</b>                           |                     |  |  |      |      |           |               |
| Continuous Source-Drain Diode Current                                    | $I_S$               | MOSFET symbol showing the integral reverse p - n junction diode    |  | -    | -    | 1.4       | A             |
| Pulsed Diode Forward Current <sup>a</sup>                                | $I_{SM}$            |  |  | -    | -    | 5.6       |               |
| Body Diode Voltage   | $V_{SD}$            | $T_J = 25\text{ }^\circ\text{C}, I_S = 1.4\text{ A}, V_{GS} = 0\text{ V}^b$  |  | -    | -    | 1.4       | V             |
| Body Diode Reverse Recovery Time   | $t_{rr}$            | $T_J = 25\text{ }^\circ\text{C}, I_F = 1.8\text{ A}, di/dt = 100\text{ A}/\mu\text{s}^b$   |  | -    | 380  | 570       | ns            |
| Body Diode Reverse Recovery Charge                                       | $Q_{rr}$            |  |  | -    | 0.94 | 1.4       | $\mu\text{C}$ |
| Forward Turn-On Time   | $t_{on}$            | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )  |  |      |      |           |               |

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300\text{ }\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

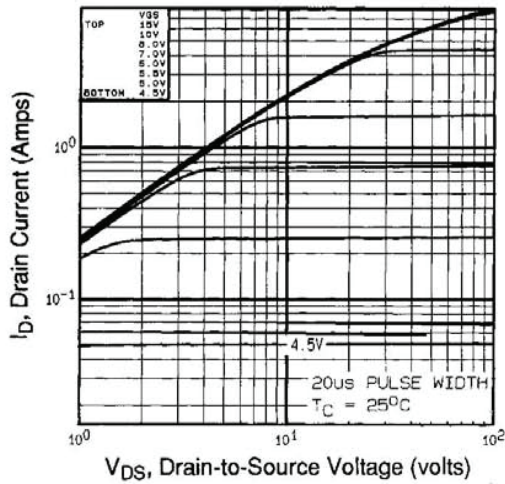


Fig. 1 - Typical Output Characteristics,  $T_C = 25\text{ }^\circ\text{C}$

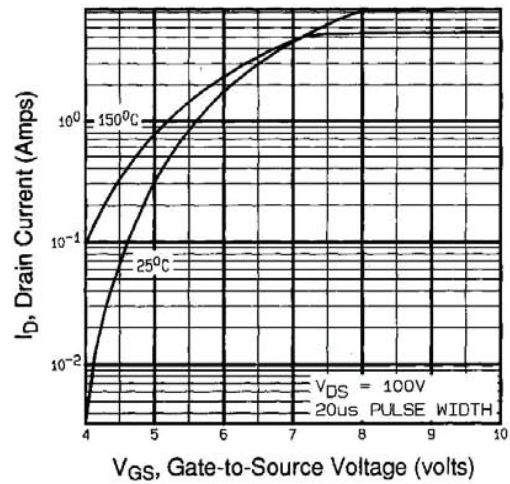


Fig. 3 - Typical Transfer Characteristics

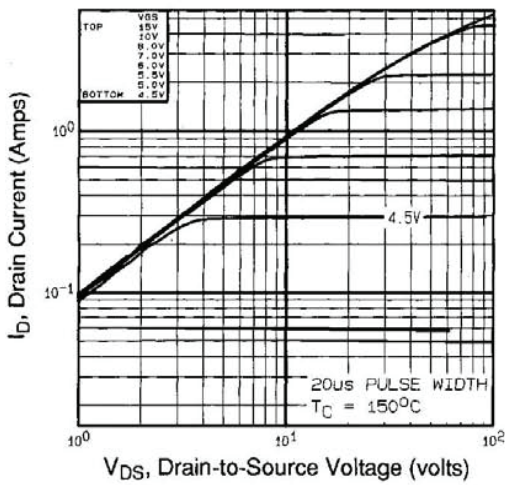


Fig. 2 - Typical Output Characteristics,  $T_C = 150\text{ }^\circ\text{C}$

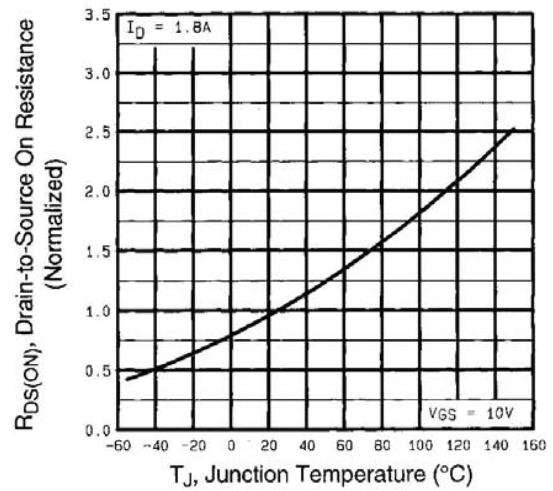


Fig. 4 - Normalized On-Resistance vs. Temperature

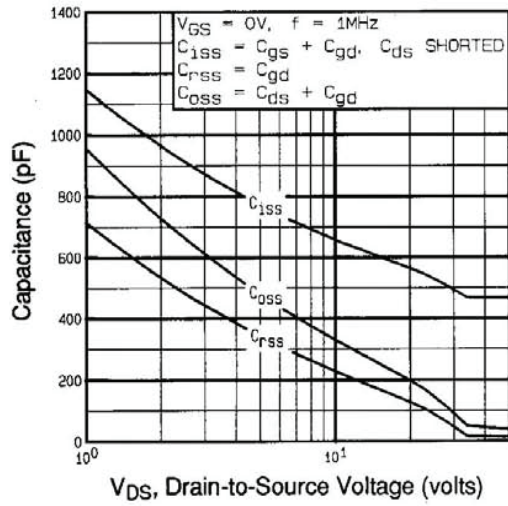


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

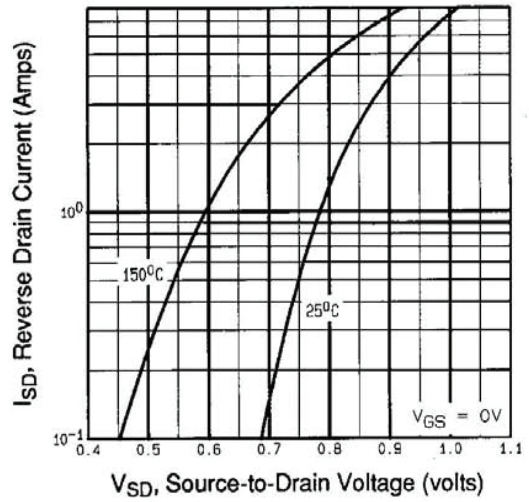


Fig. 7 - Typical Source-Drain Diode Forward Voltage

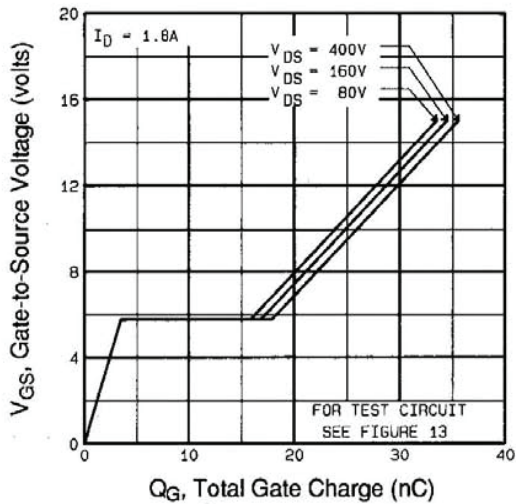


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

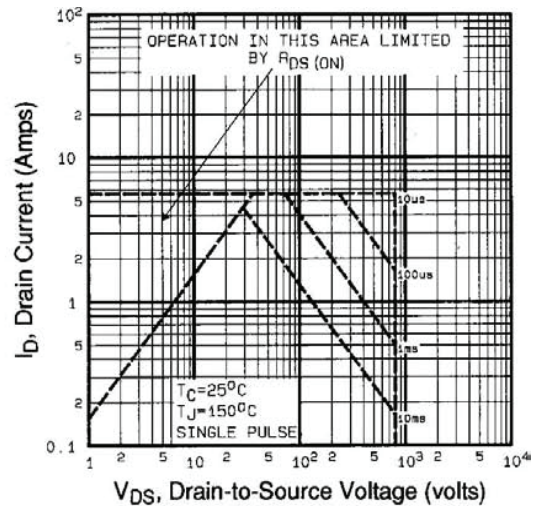


Fig. 8 - Maximum Safe Operating Area

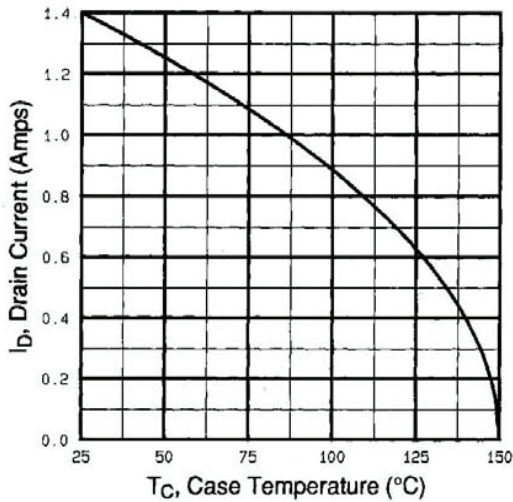


Fig. 9 - Maximum Drain Current vs. Case Temperature



Fig. 10a - Switching Time Test Circuit

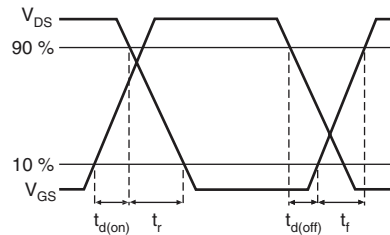


Fig. 10b - Switching Time Waveforms

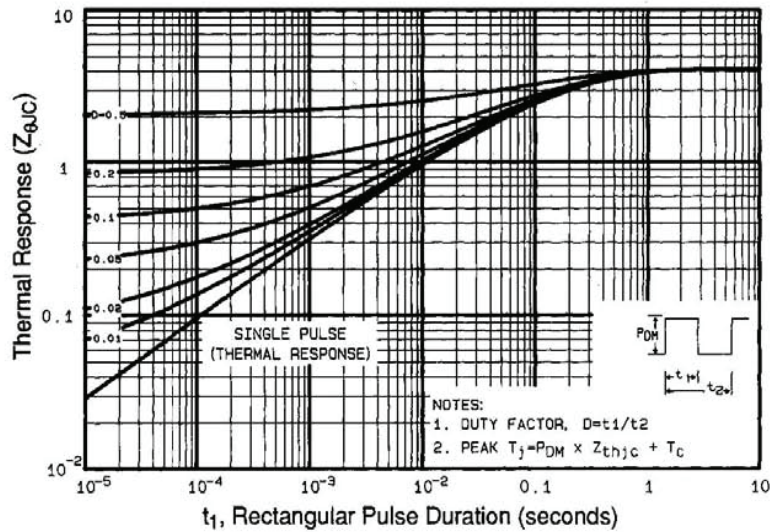


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

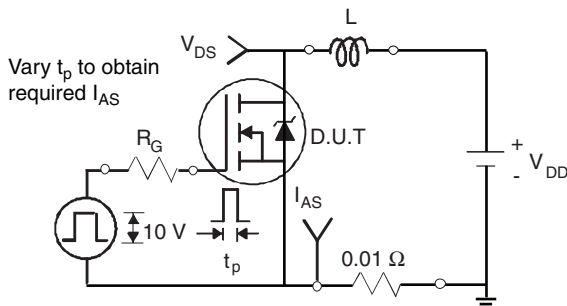


Fig. 12a - Unclamped Inductive Test Circuit

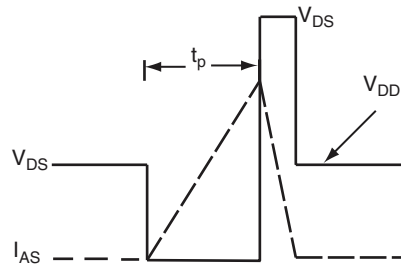


Fig. 12b - Unclamped Inductive Waveforms

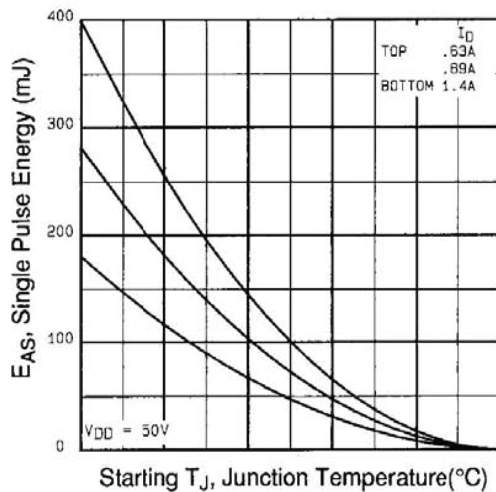


Fig. 12c - Maximum Avalanche Energy vs. Drain Current



Fig. 13a - Basic Gate Charge Waveform



Fig. 13b - Gate Charge Test Circuit

## Peak Diode Recovery $dV/dt$ Test Circuit



**Fig.14 - For N-Channel**

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